


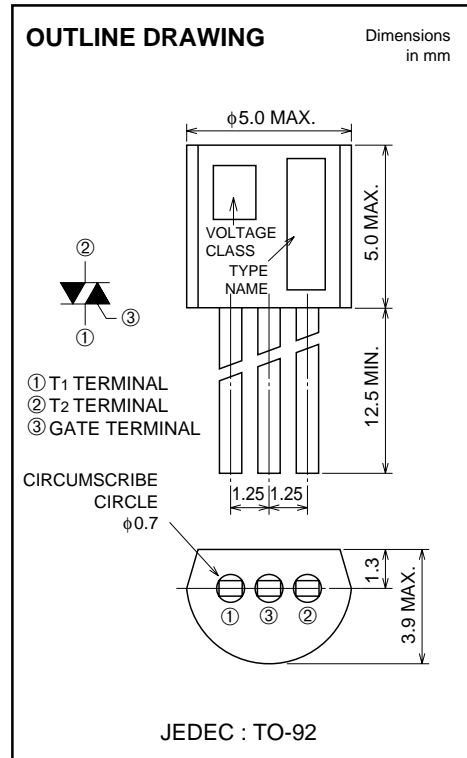
BCR08AM

LOW POWER USE
PLANAR PASSIVATION TYPE

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- I_T (RMS) 0.8A
- V_{DRM} 600V
- IRGT I, IRGT III 5mA



APPLICATION

Electric fan, air cleaner, other general purpose control applications

MAXIMUM RATINGS

Symbol	Parameter	Voltage class		Unit
		12		
V_{DRM}	Repetitive peak off-state voltage *1	600		V
V_{DSM}	Non-repetitive peak off-state voltage *1	720		V

Symbol	Parameter	Conditions	Ratings	Unit
I_T (RMS)	RMS on-state current	Commercial frequency, sine full wave 360° conduction, $T_c=56^\circ\text{C}$	0.8	A
I_{TSM}	Surge on-state current	60Hz sinewave 1 full cycle, peak value, non-repetitive	8	A
I^2t	I^2t for fusing	Value corresponding to 1 cycle of half wave 60Hz, surge on-state current	0.26	A^2s
PGM	Peak gate power dissipation		1	W
PG (AV)	Average gate power dissipation		0.1	W
VGM	Peak gate voltage		6	V
IGM	Peak gate current		0.5	A
T_j	Junction temperature		-40 ~ +125	$^\circ\text{C}$
T_{stg}	Storage temperature		-40 ~ +125	$^\circ\text{C}$
—	Weight	Typical value	0.23	g

*1. Gate open.

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ELECTRICAL CHARACTERISTICS

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
IDRM	Repetitive peak off-state current	T _j =125°C, V _{DRM} applied	—	—	1.0	mA
V _{TM}	On-state voltage	T _c =25°C, I _{TM} =1.2A, Instantaneous measurement	—	—	2.0	V
V _{RGT I}	Gate trigger voltage *2	T _j =25°C, V _D =6V, R _L =6Ω, R _G =330Ω	—	—	2.0	V
V _{RGT III}			—	—	2.0	V
I _{RGT I}	Gate trigger current *2	T _j =25°C, V _D =6V, R _L =6Ω, R _G =330Ω	—	—	5	mA
I _{RGT III}			—	—	5	mA
V _{GD}	Gate non-trigger voltage	T _j =125°C, V _D =1/2V _{DRM}	0.1	—	—	V
R _{th(j-c)}	Thermal resistance	Junction to case *3	—	—	60	°C/W
(dv/dt) _c	Critical-rate of rise of off-state commutating voltage *4	T _j =125°C	0.5	—	—	V/μs

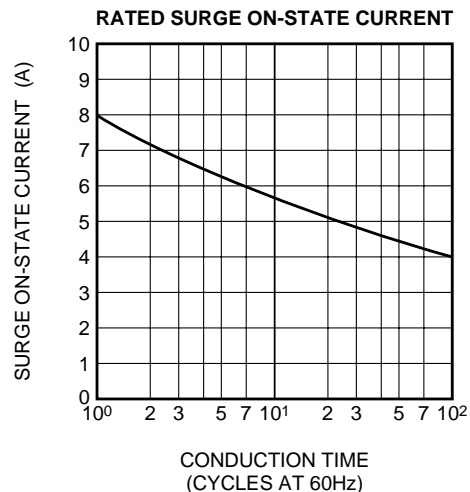
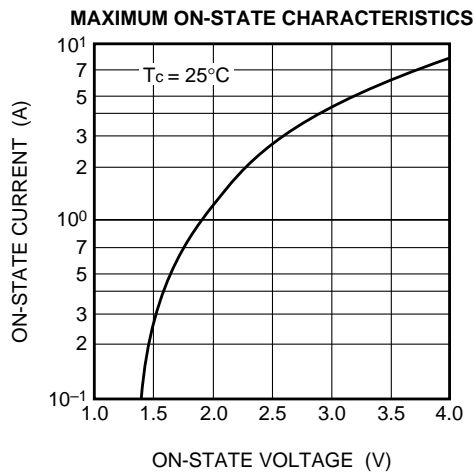
*2. Measurement using the gate trigger characteristics measurement circuit.

*3. Case temperature is measured at the T₂ terminal 1.5mm away from the molded case.

*4. Test conditions of the critical-rate of rise of off-state commutating voltage is shown in the table below.

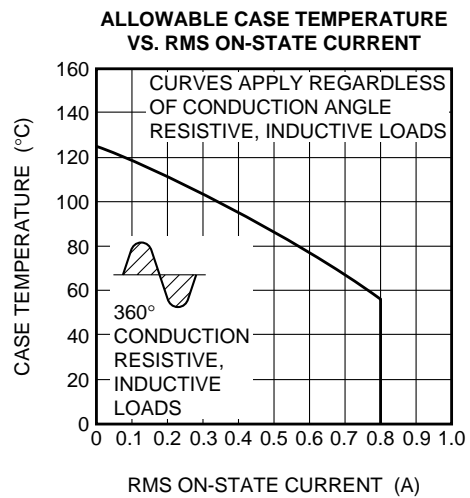
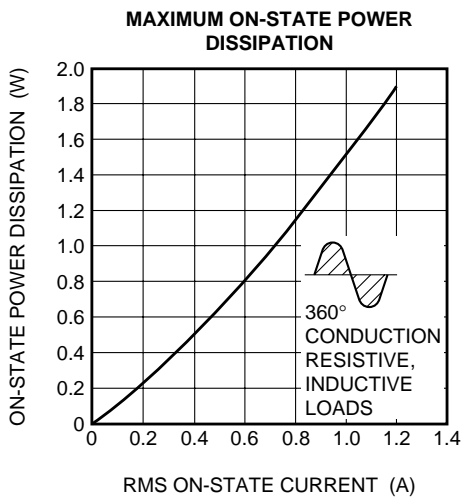
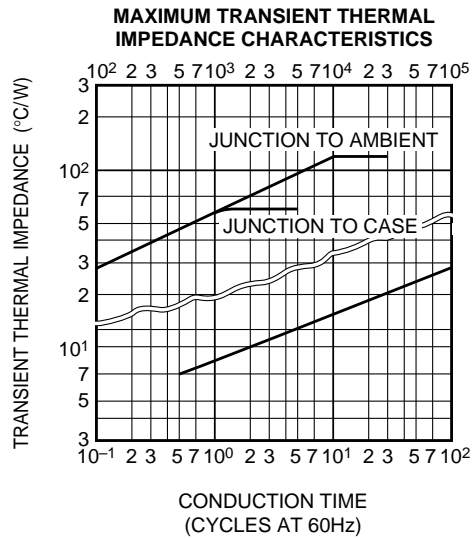
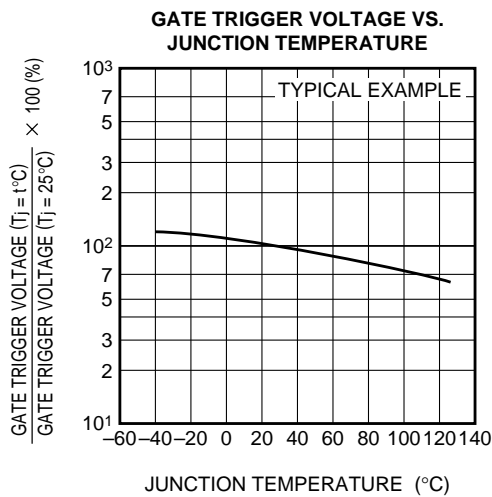
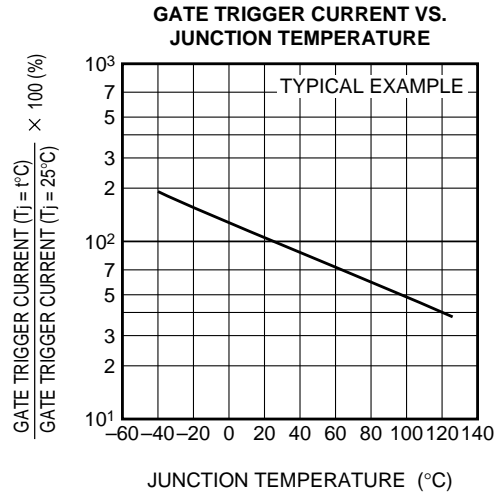
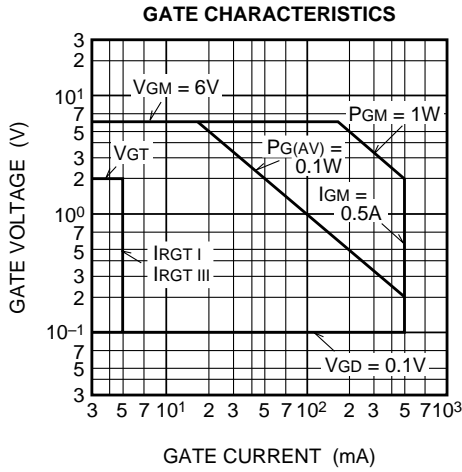
Test conditions	Commutating voltage and current waveforms (inductive load)
1. Junction temperature T _j =125°C 2. Rate of decay of on-state commutating current (di/dt) _c =-0.4A/ms 3. Peak off-state voltage V _D =400V	

PERFORMANCE CURVES



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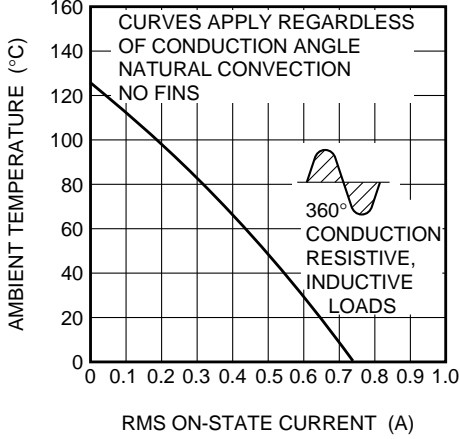
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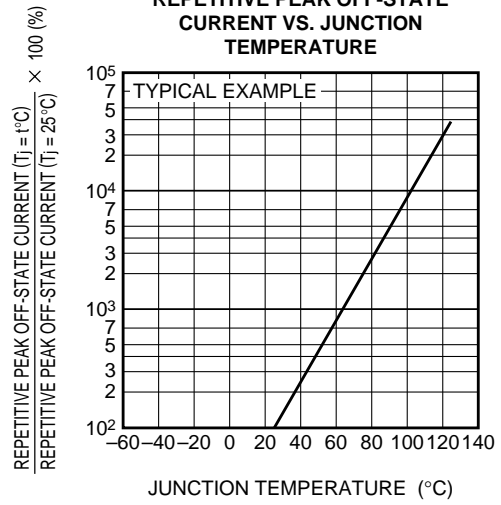
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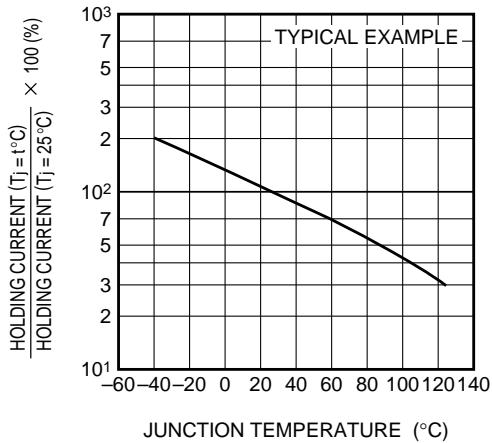
ALLOWABLE AMBIENT TEMPERATURE VS. RMS ON-STATE CURRENT



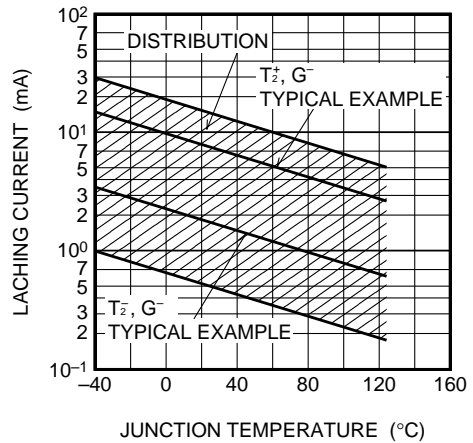
REPETITIVE PEAK OFF-STATE CURRENT VS. JUNCTION TEMPERATURE



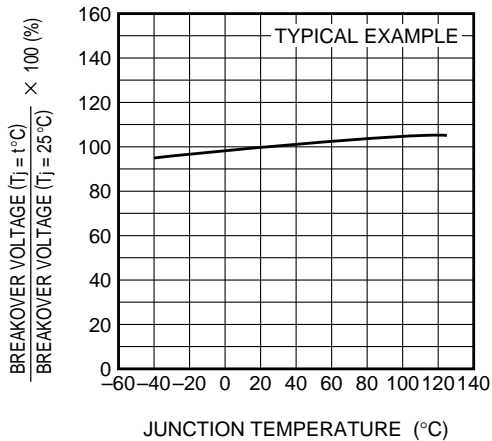
HOLDING CURRENT VS. JUNCTION TEMPERATURE



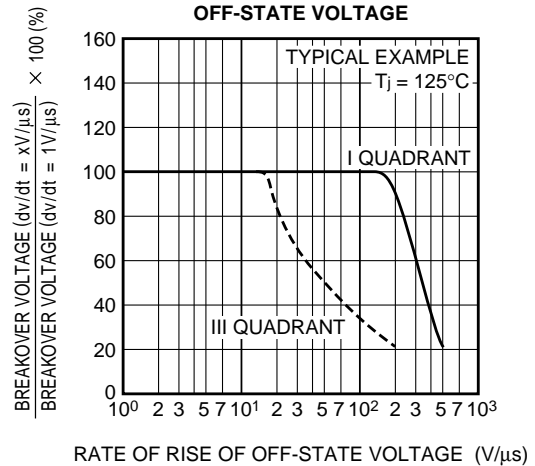
LATCHING CURRENT VS. JUNCTION TEMPERATURE



BREAKOVER VOLTAGE VS. JUNCTION TEMPERATURE

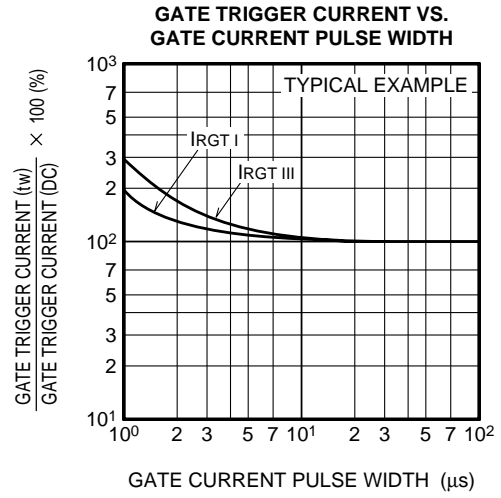
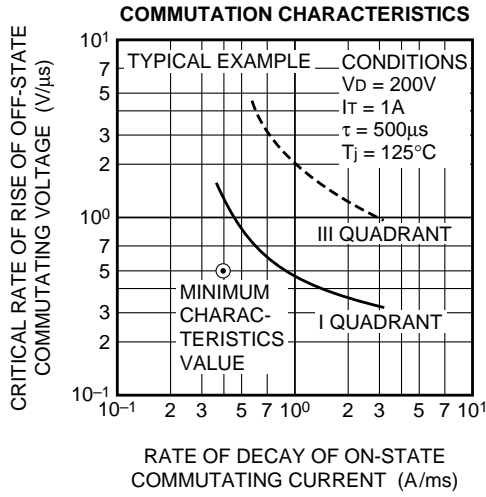


BREAKOVER VOLTAGE VS. RATE OF RISE OF OFF-STATE VOLTAGE



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LOW POWER USE
PLANAR PASSIVATION TYPE



GATE TRIGGER CHARACTERISTICS TEST CIRCUITS

